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KSC5402D/KSC5402DT — NPN Silicon Transistor, Planar Silicon Transistor

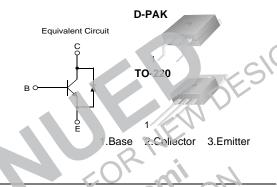
May 2024



## KSC5402D/KSC5402DT NPN Silicon Transistor, Planar Silicon Transistor

### Features

- High Voltage High Speed Power Switch Application
- Wide Safe Operating Area
- Built-in Free Wheeling Diode
- Suitable for Electronic Ballast Application
- Small Variance in Storage Time
- Two Package Choices; D-PAK or TO-220



### Absolute Maximum Ratings TA=25°C unless otherwise noted

| Symbol           | Parameter   | Value       | Units |
|------------------|---|-------------|-------|
| V <sub>CBO</sub> | Collector-Base Voltage                            | 1000        | V     |
| V <sub>CEO</sub> | Collector-Emitter Voltage                         | 450         | V     |
| V <sub>EBO</sub> | Emitter-Base Voltage                              | 12          | V     |
| ۱ <sub>C</sub>   | Collector Current (DC)                            | 2           | А     |
| I <sub>CP</sub>  | "Collector Current (Puise)                        | 5           | А     |
| IB               | Base Current (DC)                                 | 1           | А     |
| IBP              | *Base Curront (Pulse)                             | 2           | А     |
| P <sub>c</sub>   | Power Dissipation (T <sub>C</sub> =25°C) : D-PAK* | 30          | W     |
|                  | : TO-220  | 50          | W     |
| TJ               | Junction Temperature                              | 150         | °C    |
| T <sub>STG</sub> | Storage Temperature                               | - 65 to 150 | °C    |

Pulse Test: Pulse Width=5ms, Duty Cycle<10%

## Thermal Characteristics TA=25°C unless otherwise noted

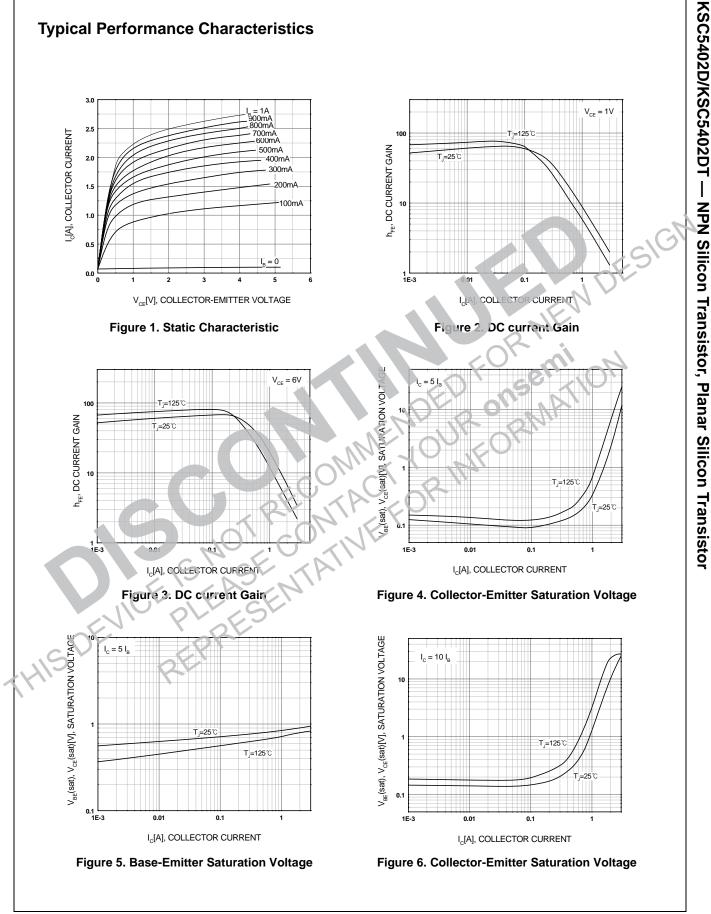
| Symbol              | Parameter   |                     | Rat    | Units |      |
|---------------------|---|---------------------|--------|-------|------|
|                     |   |                     | TO-220 | D-PAK |      |
| $R_{	ext{	heta}JC}$ | Thermal Resistance  | Junction to Case    | 2.5    | 4.17* | °C/W |
| $R_{	hetaJA}$       |   | Junction to Ambient | 62.5   | 50    | °C/W |
| ΤL                  | Maximum Lead Temperature for Soldering Purpose ; 1/8" from Case for 5 Seconds |                     | 270    | 270   | °C   |

\* Mounted on 1" square PCB (FR4 ro G-10 Material)

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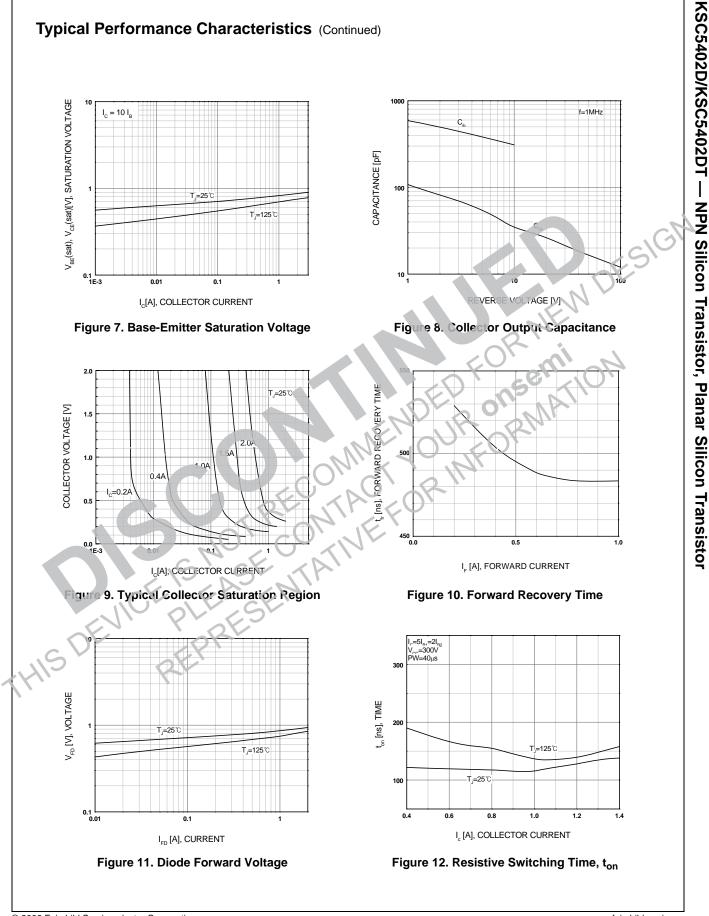
|                       | Parameter                               | Test Condition                                 | on  | Min. | Тур.         | Max.           | Units          |
|-----------------------|---|--|---|------|--------------|----------------|----------------|
| $BV_{CBO}$            | Collector-Base Breakdown<br>Voltage     | I <sub>C</sub> =1mA, I <sub>E</sub> =0         |   | 1000 | 1090         |                | V              |
| BV <sub>CEO</sub>     | Collector-Emitter Breakdown<br>Voltage  | I <sub>C</sub> =5mA, I <sub>B</sub> =0         |   | 450  | 525          |                | V              |
| $BV_{EBO}$            | Emitter-Base Breakdown<br>Voltage       | I <sub>E</sub> =1mA, I <sub>C</sub> =0         |   | 12   | 14           |                | V              |
| I <sub>CES</sub>      | Collector Cut-off Current               | V <sub>CES</sub> =1000V, I <sub>EB</sub> =0    | T <sub>A</sub> =25°C<br>T <sub>A</sub> =125°C |      | 0.03         | 100<br>500     | μΑ<br>μΑ       |
| I <sub>CEO</sub>      | Collector Cut-off Current               | V <sub>CE</sub> =450V, V <sub>B</sub> =0       | T <sub>A</sub> =25°C                          |      | 0.3          | 100            | μA             |
| I <sub>EBO</sub>      | Emitter Cut-off Current                 | V <sub>EB</sub> =10V, I <sub>C</sub> =0        | T <sub>A</sub> =125°C                         |      | 15<br>0.01   | 500<br>100     | μΑ<br>μΑ       |
| h <sub>FE</sub>       | DC Current Gain                         | V <sub>CE</sub> =1V, I <sub>C</sub> =0.4A      | T <sub>A</sub> =25°C<br>T <sub>A</sub> =12°C  | 14   | 29<br>17     |                | R <sup>2</sup> |
|                       |   | V <sub>CE</sub> =1V, I <sub>C</sub> =1A        |   | 6    | 9            | $\overline{V}$ |                |
| V <sub>CE</sub> (sat) | Collector-Emitter Saturation<br>Voltage | I <sub>C</sub> =0.4, I <sub>B</sub> =0.04      | T <sub>A</sub> =25°C                          | R    | 0.25<br>0.4  | 0.6<br>1.0     | V<br>V         |
|                       |   | I <sub>C</sub> =1A, I <sub>B</sub> =0.2A       | T <sub>A</sub> =25°C                          |      | 0.3          | 0.75           | V<br>V<br>V    |
| V <sub>BE</sub> (sat) | Base-Emitter Saturation<br>Voltage      | I <sub>C</sub> =0.4A, I <sub>B</sub> =0.04A    | Γ <sub>A</sub> =125°C<br>Γ <sub>A</sub> =25°C | 0    | 0.65         | 1.2<br>1.0     | V              |
|                       | Voltage                                 | 1 <sub>C</sub> =1A, I <sub>B</sub> =0.2A       | T <sub>A</sub> =125°C<br>T <sub>A</sub> =25°C | .0   | 0.65<br>0.85 | 0.9<br>1.1     | V<br>V         |
| C <sub>ib</sub>       | Input Caracitance                       | V <sub>EB</sub> =8V, I <sub>C</sub> =0, f=1MHz | T <sub>A</sub> =125°C                         |      | 0.75<br>330  | 1.0<br>500     | V<br>pF        |
| C <sub>ob</sub>       | Output Capacitance                      | $V_{CB}=10V, I_{E}=0, f=1MH$                   | 2   |      | 35           | 100            | pF             |
| f <sub>T</sub>        | Current Gain Bandwidth<br>Product       | i <sub>C</sub> =0.5A, V <sub>CE</sub> =10V     |   |      | 11           |                | MHz            |
| VF                    | Diode Forward Voltage                   | I <sub>F</sub> =1A                             | T <sub>A</sub> =25°C                          |      | 0.86         | 1.5            | V              |
|                       | C P AS'                                 | I <sub>F</sub> =0.2A                           | T <sub>A</sub> =25°C                          |      | 0.75         | 1.2            | V              |
| SDE                   | NCK NELCE                               |  | T <sub>A</sub> =125°C                         |      | 0.6          |                | V              |
|                       | NCEPLERESEN                             | I <sub>F</sub> =0.4A                           | T <sub>A</sub> =25°C<br>T <sub>A</sub> =125°C |      | 0.8<br>0.65  | 1.3            | V<br>V         |

| Symbol                 | Parameter                              | Test Condit  | ion                   | Min.     | Тур.      | Max. | Units |
|------------------------|--|--|-----------------------|----------|-----------|------|-------|
| t <sub>fr</sub>        | Diode Froward Recvery Time             | I <sub>F</sub> =0.2A   |                       |          | 540       |      | ns    |
|                        | (di/dt=10A/μs)                         | I <sub>F</sub> =0.4A   |                       |          | 520       |      | ns    |
|                        |  | I <sub>F</sub> =1A   | T                     |          | 480       |      | ns    |
| V <sub>CE</sub> (DSAT) | Dynamic Saturation Voltage             | $\begin{array}{c} I_{C}{=}0.4A, I_{B1}{=}40mA \\ V_{CC}{=}300V \\ \hline I_{C}{=}1A, I_{B1}{=}200mA \end{array}$ | @ 1μs                 |          | 7.5       |      | V     |
|                        |  |  | @ 3µs                 |          | 2.5       |      | V     |
|                        |  |  | @ 1µs                 |          | 11.5      |      | V     |
|                        |  | V <sub>CC</sub> =300   | @ 3µs                 |          | 1.5       |      | V     |
| RESISTIVE              | LOAD SWITCHING (D.C <u>&lt;</u> 10%, I | Pulse Width=20µs)  |                       |          |           |      |       |
| t <sub>ON</sub>        | Turn On Time                           | I <sub>C</sub> =1A,  | T <sub>A</sub> =25°C  |          | 110       | 150  | ns    |
|                        |  | I <sub>B1</sub> =200mA,  | T <sub>A</sub> =125°C |          | 135       |      | ns    |
| t <sub>OFF</sub>       | Turn Off Time                          | I <sub>B2</sub> =150mA,<br>V <sub>CC</sub> =300V,  | T <sub>A</sub> =25°C  | 0.95     |           | 1.25 | μS    |
|                        |  | $R_{\rm I} = 300\Omega$  | T <sub>A</sub> =125℃  |          | 1.4       |      | μs    |
| INDUCTIVE              | LOAD SWITCHING (V <sub>CC</sub> =15V)  | L  | <u> </u>              |          |           |      | L     |
| t <sub>STG</sub>       | Storage Time                           | I <sub>C</sub> =0.4A,  | C                     |          | 0.56      | 0.65 | μS    |
| •SIG                   |  | I <sub>B1</sub> =40mA,   | T <sub>A</sub> = 25°C |          | 0.7       | 0.00 | μS    |
| t_                     | Fall Time                              | I <sub>B2</sub> =200mA,  | T_=25 C               | 2        | 60        | 175  | ns    |
| t <sub>F</sub>         |  | Vz=300V,   | -23°C                 | $\frown$ |           | 175  |       |
| 4                      | Cross over Time                        | L <sub>C</sub> =200H   |                       |          | 75<br>90  | 175  | ns ns |
| t <sub>C</sub>         | Cross-over Time                        |  | T <sub>A</sub> = 25°C |          |           | 15   | ns    |
|                        |  |  | T <sub>A</sub> =125°C |          | 90        | 0.75 | ns    |
| t <sub>STG</sub>       | Storage Time                           | I <sub>C</sub> =0 8А,<br>I <sub>B1</sub> =160mА,   | T <sub>A</sub> =25°C  |          | <u>N.</u> | 2.75 | μS    |
|                        |  | 1 <sub>B2</sub> =160m4   | T <sub>A</sub> =125°C |          | 3         |      | μS    |
| t <sub>F</sub>         | Fall Time                              | √z=30₀V.   | T <sub>A</sub> =25°€  |          | 110       | 175  | ns    |
|                        |  | I <sub>-C</sub> =200H  | T <sub>A</sub> =125°C |          | 180       |      | ns    |
| t <sub>C</sub>         | Cross-over Time                        |  | T <sub>A</sub> =25°C  |          | 125       | 350  | ns    |
|                        |  | NI F   | T <sub>A</sub> =125℃  |          | 185       |      | ns    |
| t <sub>STG</sub>       | Storage Time                           | I <sub>C</sub> =1A,  | T <sub>A</sub> =25°C  |          | 1.1       | 1.2  | μS    |
|                        |  | I <sub>B1</sub> =200mA,<br>I <sub>B2</sub> -500mA,   | T <sub>A</sub> =125°C |          | 1.35      |      | μS    |
| t <sub>F</sub>         | Fall Time                              | V <sub>7</sub> =300V,  | T <sub>A</sub> =25°C  |          | 105       | 150  | ns    |
|                        | FILASIN                                | L <sub>C</sub> =200μH  | T <sub>A</sub> =125°C |          | 75        |      | ns    |
| tç                     | Cross-over Time                        |  | T <sub>A</sub> =25°C  |          | 125       | 150  | ns    |
|                        |  |  | T <sub>A</sub> =125°C |          | 100       |      | ns    |

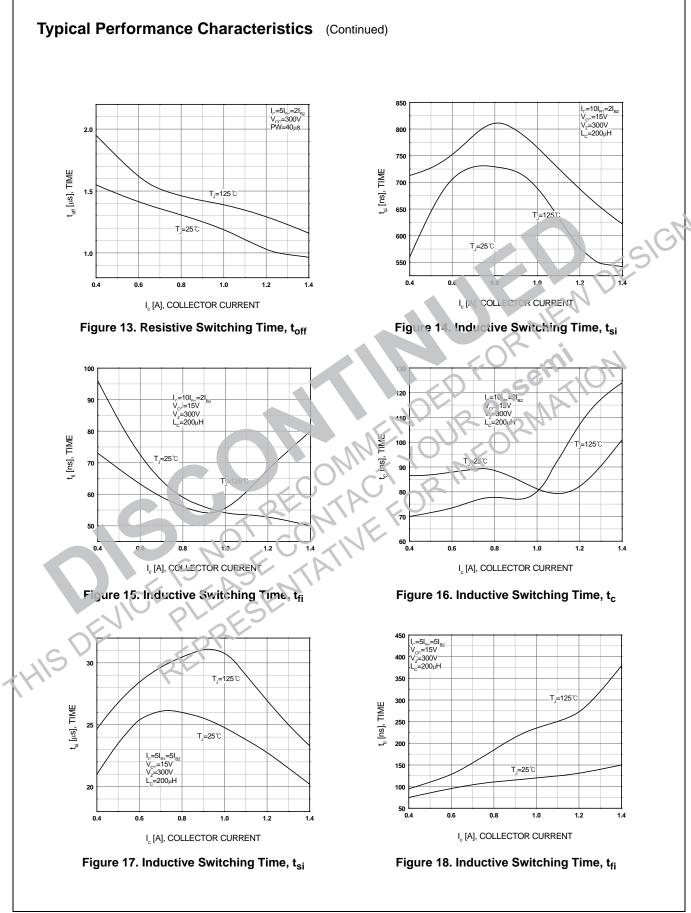


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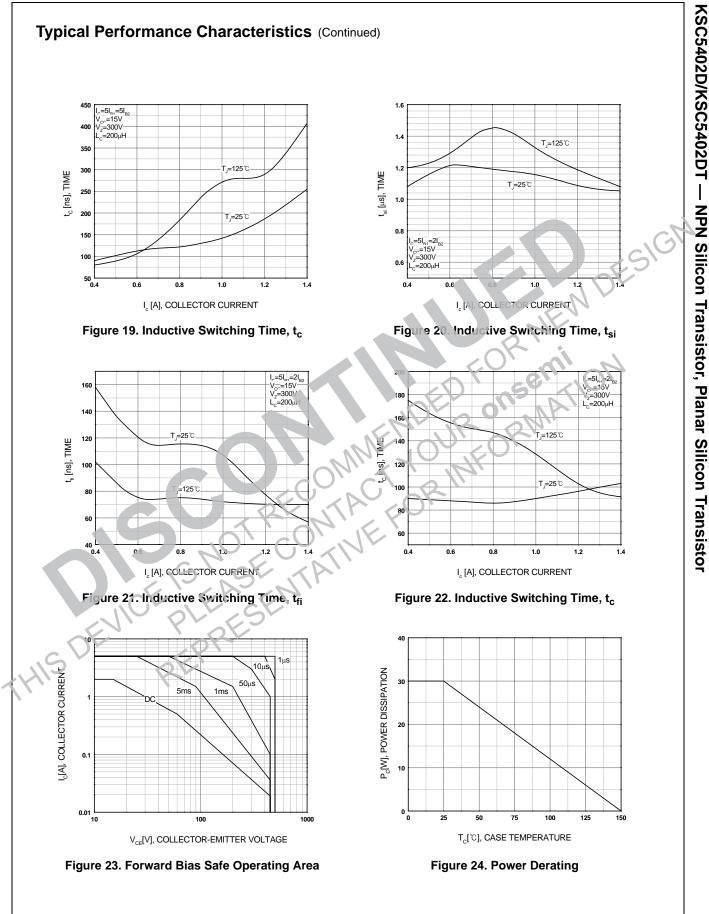


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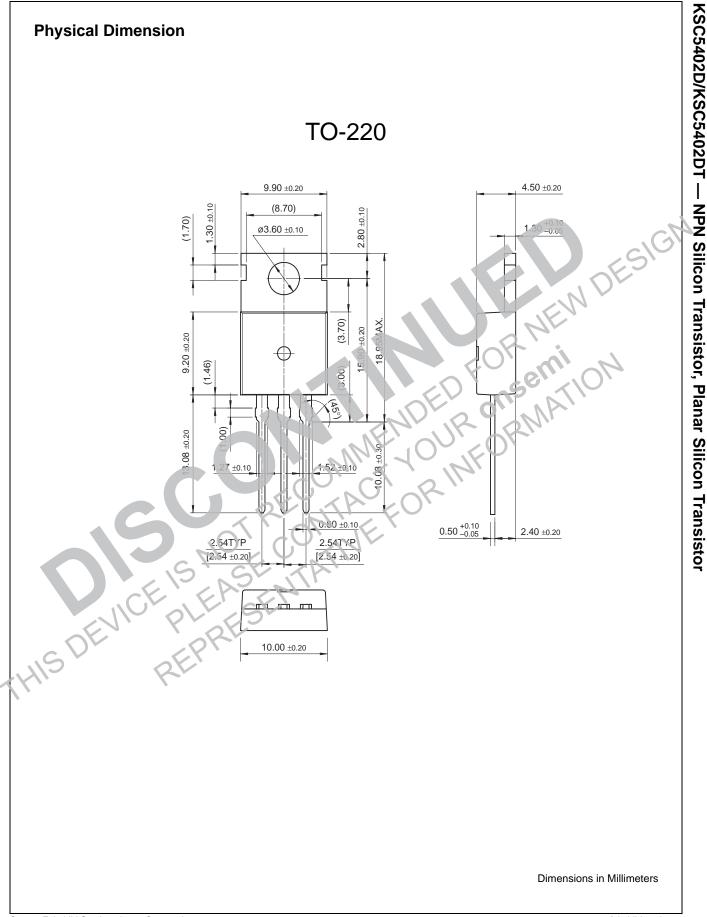


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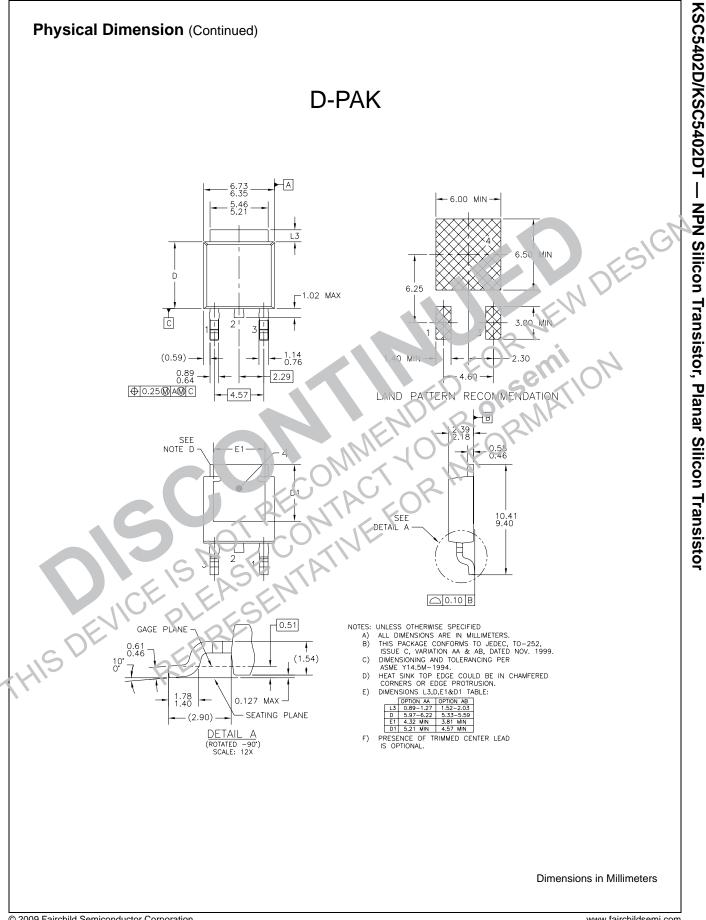
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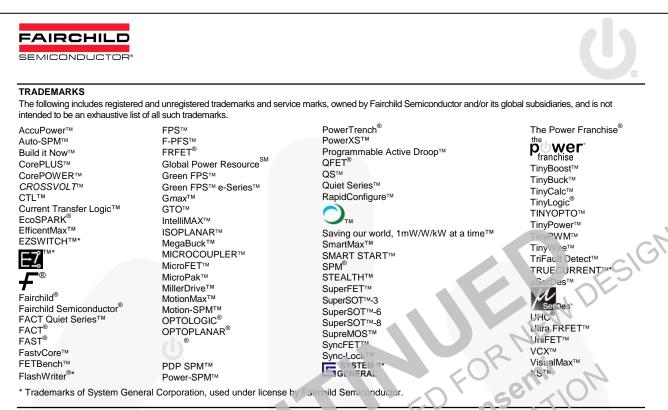


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